

# **Reflectance and Transmission Measurement Systems**

9925 Carroll Canyon Road San Diego, CA 92131 | 858-279-8034 | contact@gamma-sci.com | www.gamma-sci.com

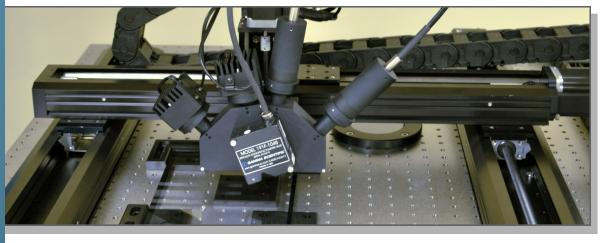
# Reflectance and Transmission Measurement Systems

#### About Gamma Scientific

Since 1961 Gamma Scientific has produced LED, display and light measurement test solutions for production and R&D environments. Gamma Scientific instruments are trusted by leading global organizations that require high-speed, precision measurements and custom configurations for the most challenging environments. Gamma Scientific also operates a NVLAP accredited laboratory that performs LM-79/LM-80 LED testing and is ISO 17025 compliant. NVLAP Lab Code 200823-0.

To view the complete line of test and measurement solutions from Gamma Scientific, please visit our website at <u>www.gamma-sci.com</u>.

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Gamma Scientific's Reflectance and Transmission Measurement Systems provide quick spectral measurement of anti-reflection, band-pass and other thin film coatings on polished substrates

Gamma Scientific provides a unique, high performance option for reflectance and transmission testing. Controlled optical geometry and industry leading spectroradiometer performance offer quick, accurate reflection/transmission measurements for any glass or polished transmissive element.

When measuring reflectance, Gamma Scientific's unique technology allows manufacturers to perform single sided inspection on the first surface of any glass or polished, transmissive element while excluding the second surface.

These systems capture complete spectral and colorimetric properties of thin film coatings with scan times typically less than one second.

#### Specular and Diffuse Measurement Systems for Measuring Virtually Any Sample

Reflectance and Transmission test systems from Gamma Scientific are available in several configurations. Depending on the sample type and desired measurement result, a variety of system configurations are available for testing either polished (specular) or rough (diffuse) samples. A production selection guide is included in this brochure to help in configuring the best system for your needs.

These systems are ideal for manufacturers who need to obtain fast and accurate measurements of flat panel display glass, anti-reflection coating inspection, photovoltaic (solar cell) coatings, optical filters, lens coatings, paint samples, diffuse plastics and more.

Regardless of the sample, Gamma Scientific offers a solution for your reflectance or transmission measurement needs.





# **Reflectance Measurement Systems**

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### Features

- Isolated First Surface Measurement of Thin Glass >500 µm Thick
- Complete Spectral Analysis
- Test Coating Uniformity and Color
- Full Cycle Testing for R&D or Production

### System Types

- Fully Automated—Integrated Production Line Reflectance Measurement
- Semi-Automatic—Programmable X-Y Stage for Rapid Inspection, R&D, QA
- Tabletop and Handheld Systems—Primarily for R&D or Small Scale QA

### **Applications**

- Flat Panel Display Glass
- Anti-Reflection (AR) Coating Inspection
- Touchscreen Display Glass
- Optical Filters/Lens Coatings
- Physical Vapor Deposition Coating Inspection (PVD)

### System Components

- Gamma Scientific Spectroradiometers
- Model 191 Specular Gonioreflectometer Heads
- <u>RS-4 Power Supplies</u>





## Transmission Measurement Systems



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### Features

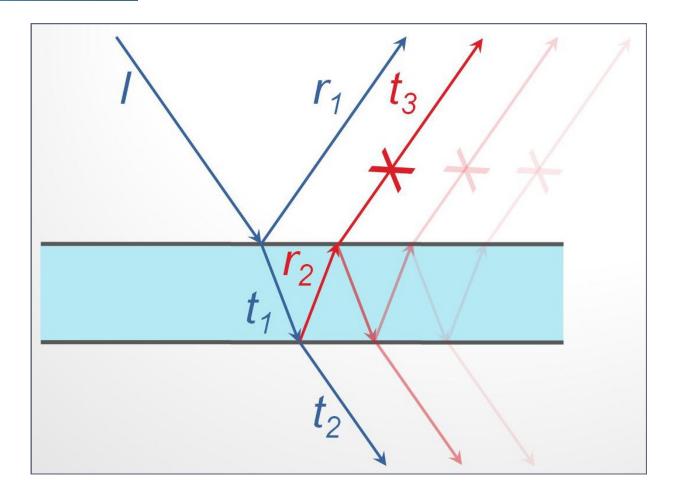
- Full Transmission Measurement of Specular or Diffuse Samples
- Complete Spectral Analysis
- Haze Measurement Option Available
- Test Sample Uniformity and Color
- Full Cycle Testing for R&D or Production
- Handheld Systems or Custom Automated Production Systems

### Applications

- Plastic Films and Tapes
- ITO Film Assemblies
- Protective Coatings
- Flat Panel Display Glass
- Anti-Reflection (AR) Coating Inspection
- Optical Filters/Lens Coatings
- Physical Vapor Deposition (PVD)



# Reflectance Measurement Technology



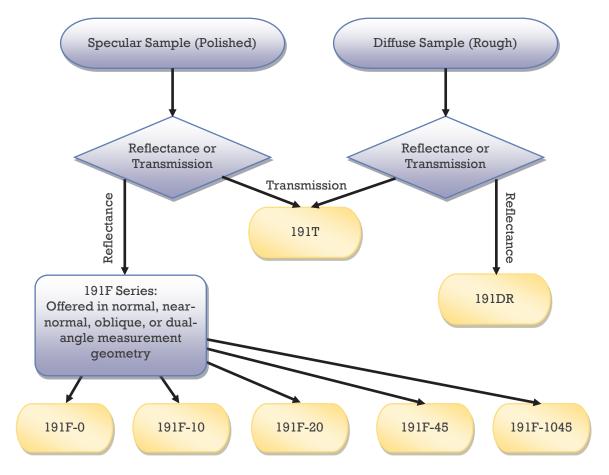
- Gamma Scientific 191F Series Optical Heads isolate the first surface reflection
- The second surface is completely eliminated in a non-destructive manner
- Light reflecting off each surface will be slightly offset
- This offset is used to mechanically block light reflected off lower surfaces





Reflectance and Transmission Manual System Selection Guide

### Manual System Selection Guide



Choose angle based on application requirements Model numbers above are specified as "191F-\*Angle\*"

Production line and custom angle systems are also available, please inquire for your custom solution

### System Components

- 191 Series Optical Heads
  - Select based on sample type and measurement requirements
- <u>GS-1220 Series Spectroradiometers</u>
  - Select based on desired spectral range
- <u>RS-4 Series Constant Current Power Supply</u>
  - For powering 191 Series light sources
- Gamma Scientific ARMeasure Reflectance Software
  - For spectral data collection and colorimetric analysis



# 191 Series Optical Head Specifications

| 191 Series Optical Heads                        |   |   |   |   |
|---|---|---|---|---|
| 191 Series Optical Head                         | 191F  | 191T  | 191C  | 191DR   |
| Measurement Type                                | Specular Reflection<br>or Total Reflection  | Total Transmission  | Specular Reflection   | Diffuse Reflection  |
| Sample Types                                    | Glass, Plastic, Metal, or any<br>Polished Substrate   | Glass, Plastic, or any<br>Transmissive Element  | Glass, Plastic, Metal, or any<br>Polished Substrate                                       | Opaque Materials, Matte<br>Surfaces, Rough Substrates                                       |
| Illumination Angle                              | Fixed Angle<br>0°, 10°, 20°, or 45° Options<br>or Dual Angle 10° and 45°  | 0°  | 10° to 45° Variable   | 45°   |
| Viewing Angle                                   | Matches Selected Illumination<br>Angle  | 2п (180°)   | 10° to 45° Variable   | 45°   |
| System Configurations                           | Handheld, Tabletop, Semi-<br>Automatic, Fully Automated   | Tabletop  | Handheld  | Tabletop (Sphere Based)   |
| Minimum Sample Thickness                        | Dependent on Angle<br>(transparent samples)   | None (transparent samples)  | 1.5mm (transparent samples)<br>None (opaque samples)                                      | None (opaque samples)   |
| Spectral Range                                  | 365nm-900nm (default)<br>UV / IR Options Available  | \$ 265nm-900nm  |   | 365nm-900nm<br>UV / IR Options Available  |
| Illumination Spot Size<br>(Area of Analysis)    | 1mm x 10µm  | Ø 1mm, Ø 2mm, or Ø 3mm 1mm x 65µm Ø 1mm, Ø 2r   |   | Ø 1mm, Ø 2mm, or Ø 3mm  |
| Typical Measurement Speed<br>(Sample Dependent) | ≈500-1000ms   | ≈1000-3000ms  | ≈2000-15000ms   | ≈1000-3000ms  |
| Optical Head Dimensions                         | Varies Depending on<br>Model/Angle  | Height: 350mm (13.75in)<br>Width: 205mm (8.0in)<br>Depth: 225mm (8.85in)<br>Weight: 3.5kg (7.75lbs) | Height: 230mm (9in)<br>Width: 150mm (6in)<br>Depth: 150mm (6in)<br>Weight: 1.6kg (3.5lbs) | Height: 300mm (12in)<br>Width: 1000mm (40in)<br>Depth: 300mm (12in)<br>Weight: 12kg (25lbs) |
|   |   | Accuracy  |   |   |
| Spectral Reflectance/<br>Spectral Transmission  | ± 0.2%  | ± 0.2% ± 0.5% ± 0.5% ± 0.5%   |   | ± 0.5%  |
| Tristimulus (CIE 1931 X, Y, Z)                  | ± 0.05  | ± 0.05 ± 0.05 ± 0.05  |   | ± 0.05  |
| Chromaticity (CIE 1931 x, y)                    | ± 0.002   | ± 0.005   | ± 0.005 ± 0.005 ± 0.00  |   |
| LAB Color (CIE 1976 L*, a*, b*)                 | L* ± 1.0 a*, b* ± 0.8   | L* ± 2.0 a*, b* ± 0.8   | L* ± 2.0 a*, b* ± 0.8   | L* ± 2.0 a*, b* ± 0.8   |
| Reported Parameters                             |   |   |   |   |
| Spectral Data                                   | Reflectance/Transmission as a function of wavelength  |   |   |   |
| Colorimetric Data                               | Tristimulus 1931 X, Y, Z<br>Tristimulus 1964 X, Y, Z<br>CIE 1931 x, y<br>UCS 1960 u, v<br>UCS 1976 u, v<br>CIE 1976 L*, a*, b*<br>CIE 1976 L*, u*, v* |   |   |   |
| Illuminant Weighting                            | Illuminant A, Illuminant B, Illuminant C, Illuminant D65, or User Specified Custom Illuminant   |   |   |   |
| Wavelength Data                                 | Dominant Wavelength, Peak Wavelength  |   |   |   |

# GS-1220 Spectroradiometers

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### High Speed Light Measurement

GS-1220 <u>spectroradiometers</u> are optimized for quality control and high speed light measurement applications, with up to 100 ms optical integration time.

The GS-1220 spectroradiometer features a proprietary optical design and back illuminated CCD technology that provides exceptional low-light measurements, superior blue light sensitivity and highly accurate measurements of wavelength, color and power.

The 2048 pixel back illuminated CCD is temperature cooled for superior instrument repeatability.

Original system calibration is performed in Gamma Scientific's NVLAP accredited laboratory using NIST-traceable standards.

#### Features

- High resolution, temperature cooled-back illuminated 2048 pixel CCD Sensor
- Exceptional accuracy via high-resolution bandwidth coverage
- Superior wavelength and color accuracy
- Near-real-time measurement
- Spectral ranges: 250-900 nm, 360-900 nm, 360-1100 nm
- NIST-traceable calibration
- Integrated neutral density filter wheel
- Hardware input/output trigger
- Windows based control/analysis software with Excel integration

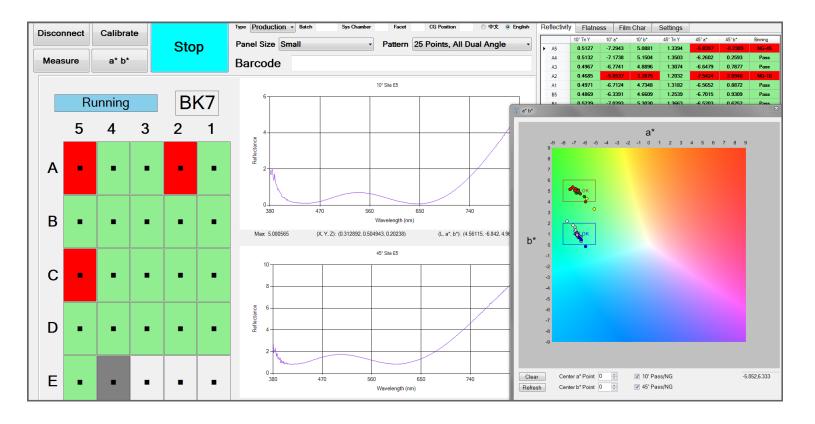
### Trusted for Over 50 Years

As the inventors of the first high-performance, computer-controlled LED spectroradiometers, Gamma Scientific has continued to set the standard in spectroradiometer accuracy and reliability. Gamma Scientific instruments have been trusted by the world's leading organizations to provide accurate measurements for over 50 years.





# Gamma Scientific ARMeasure Reflectance Software



## Features

- Programmable, Multi-Location Measurement
- Real-Time a\*, b\* Color Chart
- Binning and Pass/Fail Compatibility
- Automated Calibration
- Simultaneous 10° and 45° Measurements
- Bar Code Reader (optional)



## 191F Reflectance Measurement Systems

|  | Optical Specifications  |   |   |   |
|--|---|---|---|---|
| 191 Optical Head                             | 191F-0  | 191F-10 191F-20   |   | 191F-45   |
| Measurement Type                             | Total Specular Reflection   | First Surface or Total First Surface or Total Specular Reflection Specular Reflection     |   | First Surface or Total<br>Specular Reflection   |
| Sample Types                                 | Glass<br>Plastic<br>Metal<br>Any polished substrate   | Glass<br>Plastic<br>Metal<br>Any polished substrate                                       | Glass<br>Plastic<br>Metal<br>Any polished substrate                                       | Glass<br>Plastic<br>Metal<br>Any polished substrate                                       |
| Illumination Angle                           | 0°  | 10°   | 20°   | 45°   |
| Viewing Angle                                | 0°  | 10°   | 20°   | 45°   |
| Minimum Sample Thickness                     | None (transparent samples)<br>None (opaque samples)   | 0.5mm (transparent samples)<br>None (opaque samples)                                      | 0.35mm (transparent samples)<br>None (opaque samples)                                     | 0.15mm (transparent samples)<br>None (opaque samples)                                     |
| Maximum Sample Thickness                     | None  | None  | None  | None  |
| Minimum Sample Size                          | None  | 2.0in (50mm) diameter or<br>1.75 x 1.75in (45 x 45mm) square                              | 2.0in (50mm) diameter or<br>1.75 x 1.75in (45 x 45mm) square                              | 2.0in (50mm) diameter or<br>1.75 x 1.75in (45 x 45mm) square                              |
| Maximum Sample Size                          | Maximum 3.0in (75mm) diameter   | None  | None  | None  |
| Spectral Range                               | 365nm-1100nm  | 365nm-1100nm 365nm-1100nm   |   | 365nm-1100nm  |
| Illumination Spot Size<br>(Area of Analysis) | Ø 0.5mm   | 1mm x 10µm 1mm x 10µm   |   | 1mm x 10µm  |
| Measurement Speed<br>(Sample Dependent)      | ≈500-10000ms  | ≈300-3000ms ≈300-3000ms   |   | ≈300-3000ms   |
| Calibration Reference Standard               | 1in (25mm) BK-7 Polished Glass  | 6in (150mm) BK-7 Polished Glass 6in (150mm) BK-7 Polished Glass 6in (1                    |   | 6in (150mm) BK-7 Polished Glass   |
| Optical Head Dimensions                      | Height: 375mm (15in)<br>Width: 300mm (12in)<br>Depth: 300mm (12in)<br>Weight: 2.25kg (5lbs)   | Height: 230mm (9in)<br>Width: 150mm (6in)<br>Depth: 150mm (6in)<br>Weight: 1.6kg (3.5lbs) | Height: 230mm (9in)<br>Width: 150mm (6in)<br>Depth: 150mm (6in)<br>Weight: 1.6kg (3.5lbs) | Height: 230mm (9in)<br>Width: 150mm (6in)<br>Depth: 150mm (6in)<br>Weight: 1.6kg (3.5lbs) |
|  | Accuracy  |   |   |   |
| Spectral Reflectance                         | ± 0.2%  | ± 0.2%  | ± 0.2% ± 0.2%   |   |
| Tristimulus (CIE 1931 X, Y, Z)               | ± 0.05  | ± 0.05 ± 0.05   |   | ± 0.05  |
| Chromaticity (CIE 1931 x, y)                 | ± 0.002   | ± 0.002   | ± 0.002 ± 0.002   |   |
| LAB Color (CIE 1976 L*, a*, b*)              | L* ± 1.0 a*, b* ± 0.8   | L* ± 1.0 a*, b* ± 0.8 L* ± 1.0 a*, b* ± 0.8   |   | L* ± 1.0 a*, b* ± 0.8   |
| Average Reflectance                          | ± 0.1   | ± 0.1   | ± 0.1   | ± 0.1   |
|  | Reported Parameters   |   |   |   |
| Spectral Data                                | Reflectance as a function of wavelength   |   |   |   |
| Colorimetric Data                            | Tristimulus 1931 X, Y, Z<br>Tristimulus 1964 X, Y, Z<br>CIE 1931 x, y<br>UCS 1960 u, v<br>UCS 1976 u, v<br>CIE 1976 L*, a*, b*<br>CIE 1976 L*, u*, v* |   |   |   |
| Illuminant Weighting                         | Illuminant A, Illuminant B, Illuminant C, Illuminant D65, or User Specified Custom Illuminant   |   |   |   |
| Wavelength Data                              | Dominant Wavelength, Peak Wavelength  |   |   |   |



### GS-191SA-1045 Semi-Automated

Dual Angle Reflectance Measurement Systems

|  | Optical Specifications  |                                   |  |
|--|---|-----------------------------------|--|
| 191 Optical Head   | 10 Degree Optics 45 Degree Optics   |                                   |  |
| Measurement Type   | First Surface Specular Reflection   | First Surface Specular Reflection |  |
| Sample Types   | Glass   | Glass                             |  |
| Illumination Angle   | 10°   | 45°                               |  |
| Viewing Angle  | 10°   | 45°                               |  |
| Minimum Sample Thickness<br>(First Surface Reflectance Only) | 0.5mm (transparent samples)   | 0.25mm (transparent samples)      |  |
| Maximum Sample Thickness                                     | 6mm   | 6mm                               |  |
| Maximum Sample Sizes   | 325mm x 225mm Panel   | 325mm x 225mm Panel               |  |
| Spectral Range   | 360nm-830nm   | 360nm-830nm                       |  |
| Illumination Spot Size<br>(Area of Analysis)                 | 1mm x 10µm  | 1mm x 10µm                        |  |
| Measurement Speed  | <1500ms   | <1500ms                           |  |
| (Sample Dependent)<br>Calibration Reference Standard         | Built in BK-7 Polished Glass  | Built in BK-7 Polished Glass      |  |
|  | Semi-Auto System Specifications   |                                   |  |
| 191 Optical Head   | 191F-1045 Dual Angle Optics   |                                   |  |
| Measurement Program Types                                    | 5 Selectable Program Types, Individually configurable for up to 5 different panel sizes<br>Program Types:<br>5 Point Cross (all points 10° & 45°), 5 Point Cross (45° on center point only),<br>3 Point Diagonal (all points 10° & 45°), 25 Point Grid (all points 10° & 45°), 40 Point Grid (all points 10° & 45°) |                                   |  |
| Measurement Locations  | Position coordinates can be individually set for 5 different panel sizes with 1mm resolution<br>Default settings have a grid starting 10mm in from each edge, with equal spacing between the corner locations   |                                   |  |
| Cycle Time   | Program dependent, each measurement point takes ~1500ms   |                                   |  |
| System Dimensions  | Height: 1.25m, Width: 1.0m, Depth: 1.0m   |                                   |  |
|  | Weight: approx. 300kg<br>Measurement Accuracy   |                                   |  |
| Spectral Reflectance   | ± 0.5% ± 0.5%   |                                   |  |
| Tristimulus (CIE 1931 X, Y, Z)                               | ± 0.05  | ± 0.10                            |  |
| Chromaticity (CIE 1931 x, y)                                 | ± 0.005   | ± 0.005                           |  |
| LAB Color (CIE 1976 L*, a*, b*)                              | L* ± 2.0 a*, b* ± 0.8 L* ± 2.0 a*, b* ± 0.8   |                                   |  |
| Average Reflectance  | ± 0.2 ± 0.2   |                                   |  |
|  | Reported Parameters   |                                   |  |
| Spectral Data  | Reflectance as a function of wavelength   |                                   |  |
| Colorimetric Data  | Tristimulus 1931 X, Y, Z<br>Tristimulus 1964 X, Y, Z<br>CIE 1931 x, y<br>CIE 1976 L*, a*, b*<br>CIE 1976 L*, u*, v*   |                                   |  |
| Wavelength Data  | Dominant Wavelength, Peak Wavelength  |                                   |  |



# GS-191FA-1045

## Rotary Reflectance Measurement Systems

|  | Optical Specifications  |  |  |  |
|--|---|--|--|--|
| 191 Optical Head   | 10 Degree Optics  | 45 Degree Optics   |  |  |
| Measurement Type   | First Surface Specular Reflection   | First Surface Specular Reflection  |  |  |
| Sample Types   | Glass   | Glass  |  |  |
| Illumination Angle   | 10°   | 45°  |  |  |
| Viewing Angle  | 10°   | 45°  |  |  |
| Minimum Sample Thickness<br>(First Surface Reflectance Only) | 0.5mm (transparent samples)   | 0.25mm (transparent samples)   |  |  |
| Maximum Sample Thickness                                     | 6mm   | 6mm  |  |  |
| Sample Sizes   | Customer Defined Panel Size<br>One Machine Can Support Three Different Panel Sizes  | Customer Defined Panel Size<br>One Machine Can Support Three Different Panel Sizes |  |  |
| Spectral Range   | 360nm-830nm   | 360nm-830nm  |  |  |
| Illumination Spot Size<br>(Area of Analysis)                 | 1mm x 10µm  | 1mm x 10µm   |  |  |
| Measurement Speed<br>(Sample Dependent)                      | <1500ms   | <1500ms  |  |  |
| Calibration Reference Standard                               | Built in BK-7 Polished Glass  | Built in BK-7 Polished Glass   |  |  |
|  | Rotary System Specifications  |  |  |  |
| 191 Optical Heads  | 191F-1045 Dual Angle Optics   |  |  |  |
| Measurement Locations<br>Per Panel                           | 3 Measurement Locations Standard, Configurable up to 5 locations<br>Configurable for 10 and 45 degree measurement at any location |  |  |  |
| Glass Stations   | 8 Glass Stations, 3 for loading/unloading and 5 for measurement optics  |  |  |  |
| Cycle Time   | <6 seconds per panel, 3 seconds maximum for loading and unloading<br>(cycle time increases if load/unload exceeds 3 seconds)      |  |  |  |
| System Dimensions  | Height: 1.75m, Width: 1.6m, Depth: 1.6m<br>Weight: approx.1000kg  |  |  |  |
|  | Measurement Accuracy  |  |  |  |
| Spectral Reflectance   | ± 0.5% ± 0.5%   |  |  |  |
| Tristimulus (CIE 1931 X, Y, Z)                               | ± 0.05  | ± 0.10   |  |  |
| Chromaticity (CIE 1931 x, y)                                 | ± 0.005   | ± 0.005  |  |  |
| LAB Color (CIE 1976 L*, a*, b*)                              | L* ± 2.0 a*, b* ± 0.8   | L* ± 2.0 a*, b* ± 0.8  |  |  |
| Average Reflectance  | ± 0.2   | ± 0.2  |  |  |
|  | Reported Parameters   |  |  |  |
| Spectral Data  | Reflectance as a function of wavelength   |  |  |  |
| Colorimetric Data  | Tristimulus 1931 X, Y, Z<br>Tristimulus 1964 X, Y, Z<br>CIE 1931 x, y<br>CIE 1976 L*, a*, b*<br>CIE 1976 L*, u*, v*               |  |  |  |
| Wavelength Data  | Dominant Wavelength   |  |  |  |



## 191T Transmission Measurement Systems

|  | Optical Specifications  |  |  |
|--|---|--|--|
| 191 Optical Head                             | 191T  |  |  |
| Measurement Type                             | Total Transmission  |  |  |
| Sample Types                                 | Glass or any polished transmissive element  |  |  |
| Illumination Angle                           | 0°  |  |  |
| Viewing Angle                                | 2n (180°)   |  |  |
| Minimum Sample Thickness                     | None  |  |  |
| Maximum Sample Thickness                     | 15mm  |  |  |
| Minimum Sample Size                          | Ø 10mm  |  |  |
| Maximum Sample Size                          | 200mm x 200mm Panel   |  |  |
| Illumination Spot Size<br>(Area of Analysis) | Ø 1mm, Ø 2mm, or Ø 3mm (User selectable at time of purchase)  |  |  |
| Measurement Speed<br>(Sample Dependent)      | ≈300-3000ms   |  |  |
| Calibration Reference Standard               | BK-7 Polished Glass   |  |  |
| Optical Head Dimensions                      | Height: 350mm (13.75in)<br>Width: 205mm (8.0in)<br>Depth: 225mm (8.85in)<br>Weight: approx. 3.5kg (7.75lbs)   |  |  |
|  | Measurement Accuracy  |  |  |
| Spectral Transmission                        | ± 0.5%  |  |  |
| Tristimulus (CIE 1931 X, Y, Z)               | ± 0.05  |  |  |
| Chromaticity (CIE 1931 x, y)                 | ± 0.005   |  |  |
| LAB Color (CIE 1976 L*, a*, b*)              | L* ± 2.0 a*, b* ± 0.8   |  |  |
| Average Transmission                         | ± 0.2   |  |  |
|  | Reported Parameters   |  |  |
| Spectral Data                                | Transmission as a function of wavelength  |  |  |
| Colorimetric Data                            | Tristimulus 1931 X, Y, Z<br>Tristimulus 1964 X, Y, Z<br>CIE 1931 x, y<br>UCS 1960 u, v<br>UCS 1976 u, v<br>CIE 1976 L*, a*, b*<br>CIE 1976 L*, u*, v* |  |  |
| Illuminant Weighting                         | Illuminant A, Illuminant B, Illuminant C, Illuminant D65, or User Specified Custom Illuminant   |  |  |
| Wavelength Data                              | Dominant Wavelength, Peak Wavelength  |  |  |

## GS-1220 Spectroradiometer Specifications

|   | Detector and Wavel   | ength Specifications         |                        |  |
|---|--|------------------------------|------------------------|--|
| Spectrometer Model  | GS-1220-0  | GS-1220-1                    | GS-1220-2              |  |
| Nominal Spectral Range  | 250-900nm UV-VIS   | 360-900nm VIS                | 360-1100nm VIS-NIR     |  |
| Datapoint Interval  | 0.32 nm  | 0.32 nm                      | 0.35 nm                |  |
| Spectral Bandwidth  | Built-In User Selectable Half-Power Bandwidth (HPBW) Bold is factory setting |                              |                        |  |
|   | 10 nm  | 10 nm                        | 10 nm                  |  |
|   | 5.0 nm   | 5.0 nm                       | 5.0 nm                 |  |
|   | 2.5 nm   | 2.5 nm                       | 2.5 nm                 |  |
|   | 1.4 nm   | 1.4 nm                       | 1.4 nm                 |  |
|   | 1.0 nm   | 1.0 nm                       | 1.0 nm                 |  |
| Wavelength Repeatability  | 0.02 nm  | 0.02 nm                      | 0.02 nm                |  |
| Wavelength Accuracy   | +/- 0.1 nm   | +/- 0.1 nm                   | +/- 0.1 nm             |  |
|   | Accu   | Iracy                        |                        |  |
| Luminous Intensity  | ± 1%   | ± 1%                         | ± 1%                   |  |
| Luminous Flux   | ± 1%   | ± 1%                         | ± 1%                   |  |
| Chromaticity (CIE1931 xy) <sup>2</sup>                            | x,y=±0.0015  | x,y=±0.0015                  | x,y=±0.0015            |  |
| Dominant Wavelength <sup>2</sup>                                  | ± 0.5 nm   | ± 0.5 nm                     | ± 0.5 nm               |  |
|   | Sensi  | itivity <sup>3</sup>         |                        |  |
| Luminous Intensity<br>(10:1 signal-to-noise)                      | 0.02 mcd to 15 kcd   | 0.02 mcd to 15 kcd           | 0.02 mcd to 15 kcd     |  |
| Luminous Flux <sup>4</sup><br>(12" sphere ; 10:1 signal-to-noise) | 1 mlm – 240 klm  | 1 mlm – 240 klm              | 1 mlm – 240 klm        |  |
| Illuminance Sensitivity<br>(10:1 signal-to-noise)                 | 0.02 mlux - 15,000 lux   | 0.02 mlux - 15,000 lux       | 0.02 mlux - 15,000 lux |  |
| Measuring time (range)  | 2 µsec to 2.67 sec   | 2 µsec to 2.67 sec           | 2 µsec to 2.67 sec     |  |
| Measuring Time at 1 mcd<br>(10:1 signal-to-noise)                 | 40 msec  | 40 msec                      | 40 msec                |  |
|   | Specifications for   | All Spectrometers            | 1                      |  |
| Stray Light   | Less than $1 \times 10 - 4$ (at 8 times the                                  | e HPBW from HeNe Laser Line) |                        |  |
| Spectral Sensor   | High Resolution 2048 pixel CCD Sensor  |                              |                        |  |
| Temperature Stabilized Sensor                                     | -5° C below ambient  |                              |                        |  |
| Electrical Resolution   | 16 Bit   |                              |                        |  |
| Dynamic Range (single scan)                                       | 6,670:1  |                              |                        |  |
| Computer Interface  | USB 2.0  |                              |                        |  |
| Control Software  | Light Touch LED software for Windows   |                              |                        |  |
| Dimensions:   | 5.25" H x 12.00" W x 10.20" L (13.34" cm x 30.48 cm W x 25.91 cm L )         |                              |                        |  |
| Weight  | 20 lbs. (9.1 kg)   |                              |                        |  |

1: Accuracy specifications assume sufficient signal to noise and are valid immediately after proper calibration, relative to the calibration standard.

2: Applies to colored LEDs with sufficient signal-to-noise ratio.

3: Sensitivity specifications assume a 10:1 signal-to-noise ratio for white 5000K CCT LED's.

4: Luminous flux is with a GS-IS300 integrating sphere calibrated with Deuterium and tungsten standards to cover a 250 to 860nm range

5: Specifications are subject to change at any time without notice

6: Standard Operating Range for Gamma Scientific Instruments- Temperature: Minimum: 0°C (32°F) - Maximum: 35°C (95°F); Relative Humidity (Non-Condensing): Minimum: 20% - Maximum 70%

7: Revised on April 14, 2015